



# H2M080120P

Silicon Carbide MOSFET  
N-CHANNEL ENHANCEMENT MODE

## Features

- Low On-Resistance and High Current Density
- Low Capacitance for High Frequency Operation
- Ultra-high Avalanche Ruggedness
- Positive Temperature Coefficient Device
- RoHS Compliant and Halogen Free

## Benefits

- Higher System Efficiency
- Increase Parallel Device Convenience
- Capable of 175°C High  $T_j$  Application
- Allow High Frequency Operation
- Realize Compact and Lightweight Systems

## Applications

- Switching Mode Power Supply
- DC/DC Converters, UPS, and PFC
- EV Charging Station
- Motor Drives
- Power Inverters
- Solar/Wind Renewable Energy

## Absolute Maximum Ratings

( $T_c = 25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Test Conditions	Value	Unit
Drain – Source Voltage	$V_{DS, \text{max}}$	$V_{GS}=0V, I_{DS}=100\mu\text{A}$	1200	V
Continuous Drain Current	$I_D$	$V_{GS}=20V, T_c=25^\circ\text{C}$	33	A
		$V_{GS}=20V, T_c=110^\circ\text{C}$	24	
		$t_{PW}$ limitation per Fig.15	81	
Power Dissipation	$P_D$	$T_c=25^\circ\text{C}$	224	W
Recommend Gate Source Voltage	$V_{GS, \text{op}}$	Static, recommended DC operating values	-5 to 20	V
Maximum Gate Source Voltage	$V_{GS, \text{max}}$	Transient operating limit (AC $f > 1\text{Hz}$ , duty cycle < 1%)	-10 to 25	
Junction & Storage Temperature	$T_j, T_{stg}$		-55 to 175	$^\circ\text{C}$
Soldering Temperature	$T_L$		260	
Mounting Torque	$M_D$	M3 or 6-32 screw	1.0	Nm

## Thermal Resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal Resistance, Junction to Case	$R_{\theta,JC}$		0.67		$^\circ\text{C}/\text{W}$

## Electrical Characteristics ( $T_c = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{GS}=0\text{V}, I_{DS}=100\mu\text{A}$	1200			V
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS}=10\text{V}, I_{DS}=20\text{mA}$	1.5	3	4.5	V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS}=1200\text{V}, V_{GS}=0\text{V}$		<1	50	
		$V_{DS}=1200\text{V}, V_{GS}=0\text{V}$ $T_j=175^\circ\text{C}$		10		$\mu\text{A}$
Gate-Source Leakage Current	$I_{GSS}$	$V_{GS}=20\text{V}, V_{DS}=0\text{V}$			250	nA
		$V_{GS}=20\text{V}, I_{DS}=15\text{A}$		80	110	
Drain-Source On-State Resistance	$R_{DS(\text{on})}$	$V_{GS}=20\text{V}, I_{DS}=15\text{A},$ $T_j=175^\circ\text{C}$		134		$\text{m}\Omega$
Transconductance	$g_{fs}$	$V_{DS}=9.8\text{V}, I_{DS}=15\text{A}$		6.5		S
Input Capacitance	$C_{iss}$	$V_{GS}=0\text{V}, V_{DS}=800\text{V}$		2644		
Output Capacitance	$C_{oss}$	$f=1\text{MHz}, V_{AC}=25\text{mV}$		85		
Reverse Transfer Capacitance	$C_{rss}$			8		
Effective Output Capacitance, Energy Related	$C_{o(er)}$	$V_{GS}=0\text{V},$ $V_{DS}=0 \text{ to } 800\text{V}$		202		pF
Effective Output Capacitance, Time Related	$C_{o(tr)}$	$I_D=\text{const.}, V_{GS}=0\text{V},$ $V_{DS}=0 \text{ to } 800\text{V}$		146		
Turn On Delay Time	$t_{d(on)}$			28		
Rise Time	$t_r$			64		
Turn Off Delay Time	$t_{d(off)}$			60		ns
Fall Time	$t_f$			26.4		
$C_{oss}$ Stored Energy	$E_{oss}$	$V_{GS}=0\text{V}, V_{DS}=800\text{V}$ $f=1\text{MHz}, V_{AC}=25\text{mV}$		33		$\mu\text{J}$
Turn-on Switching Energy	$E_{on}$	$V_{DS}=800\text{V}, V_{GS}=-5/+20\text{V},$ $I_D=20\text{A}, R_L=40\Omega,$ $R_{G(\text{ext})}=2.7\ \Omega$		22*		
Turn-off Switching Energy	$E_{off}$	$R_{G(\text{ext})}=2.7\ \Omega$		22*		
Internal Gate Resistance	$R_{G(\text{int.})}$	$f=1\text{MHz}, V_{AC}=25\text{mV}$		0.75		$\Omega$

\*Based on the results of calculation, note that the energy loss caused by the reverse recovery of free-wheeling diode is not included in  $E_{on}$ .

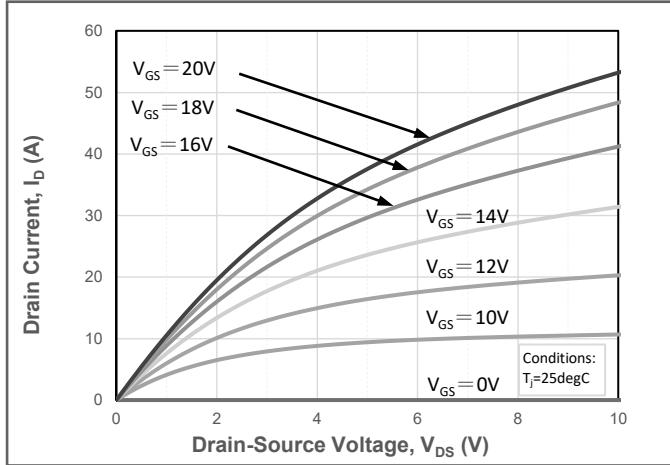
## Built-in SiC Diode Characteristics ( $T_c = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Test Conditions	Typ.	Unit
Inverse Diode Forward Voltage	$V_{SD}$	$V_{GS}=0\text{V}, I_{SD}=5\text{A}$	3	V
Continuous Diode Forward Current	$I_S$	$V_{GS}=0\text{V}, T_c=25^\circ\text{C}$	36	A
Reverse Recovery Time	$t_{rr}$	$V_{GS}=0\text{V},$	50	ns
Reverse Recovery Charge	$Q_{rr}$	$I_{SD}=20\text{A}, V_{DS}=400\text{V},$ $di/dt=300\text{A}/\mu\text{s}$	81	nC
Peak Reverse Recovery Current	$I_{rrm}$		3.2	A

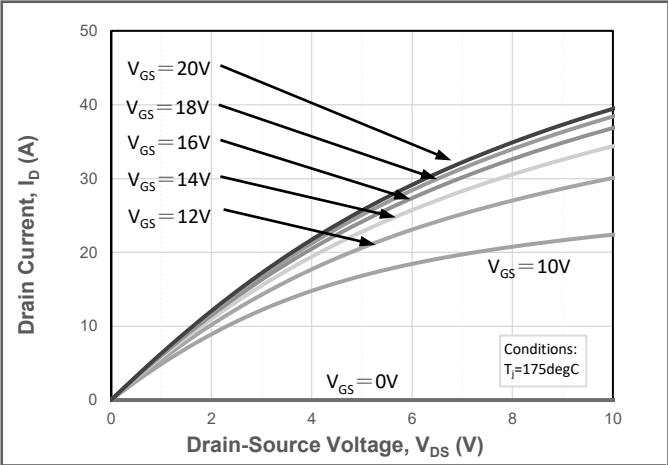
## Gate Charge Characteristics ( $T_c = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Test Conditions	Value	Unit
Gate to Source Charge	$Q_{GS}$		57	
Gate to Drain Charge	$Q_{GD}$	$V_{DS}=800\text{V},$ $V_{GS}=-5/+20\text{V},$ $I_D=20\text{A}$	23	nC
Total Gate Charge	$Q_G$		131	
Gate plateau voltage	$V_{pl}$		9.9	V

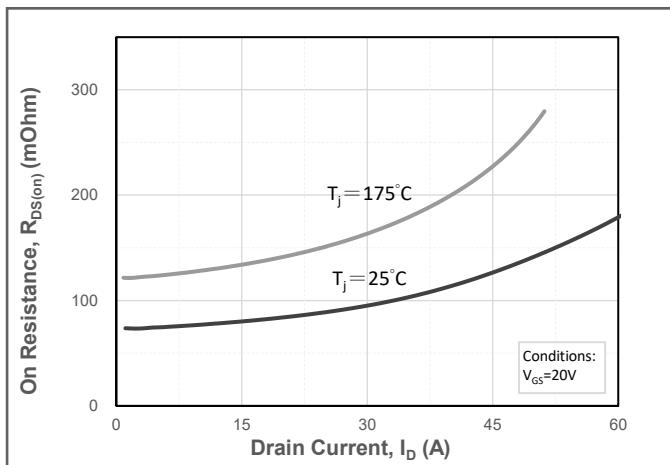
## Typical Device Performance



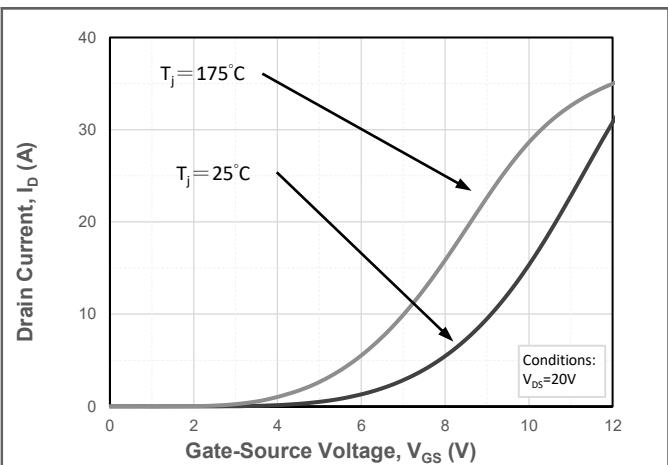
**Fig.1** Forward Output Characteristics at  $T_j=25^\circ\text{C}$



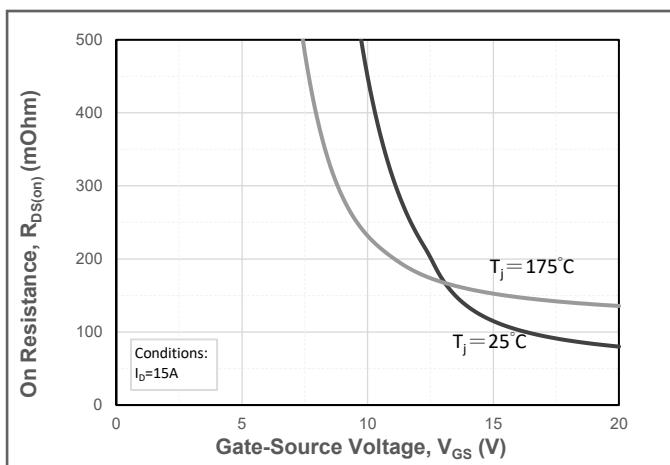
**Fig.2** Forward Output Characteristics at  $T_j=175^\circ\text{C}$



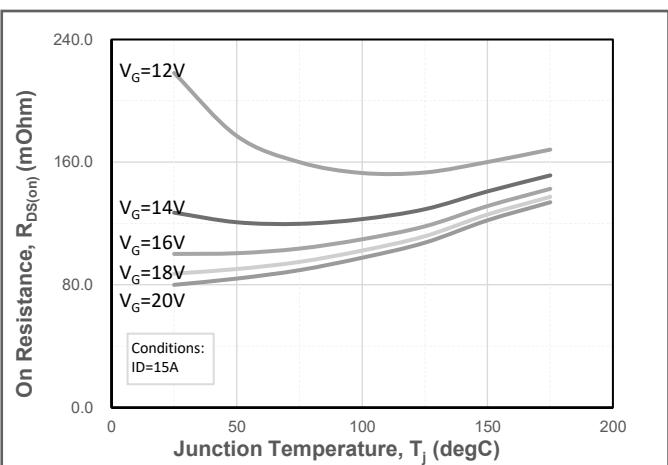
**Fig.3** On-Resistance vs. Drain Current for Various  $T_j$



**Fig.4** Transfer Characteristics for Various  $T_j$



**Fig.5** On-Resistance vs. Gate Voltage for Various  $T_j$



**Fig.6** On-Resistance vs. Temperature for Various Gate Voltage

## Typical Device Performance

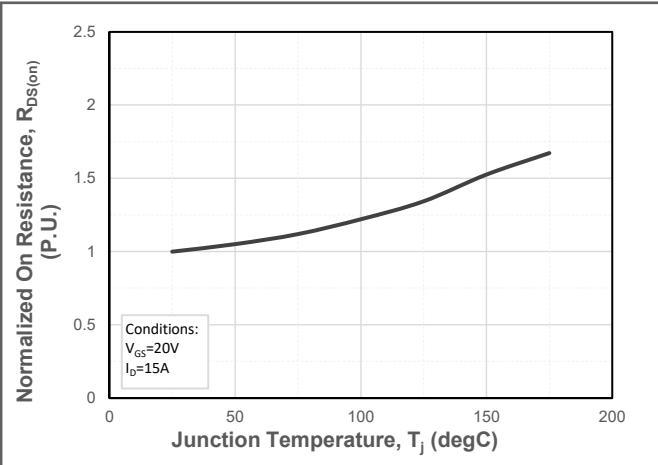


Fig.7 Normalized On-Resistance vs. Temperature

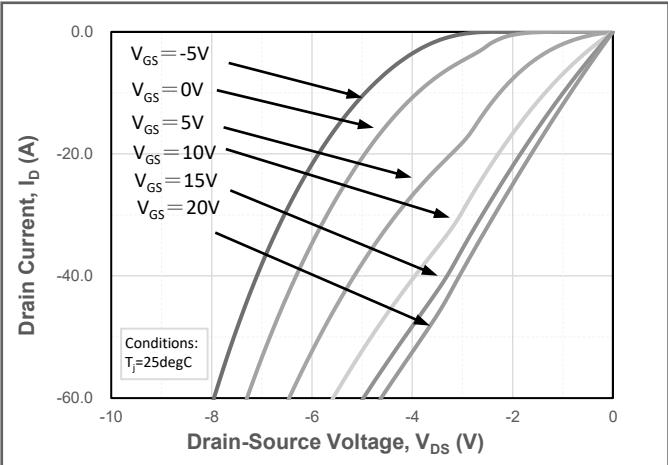


Fig.8 Reverse Output Characteristics at  $T_j = 25^\circ\text{C}$

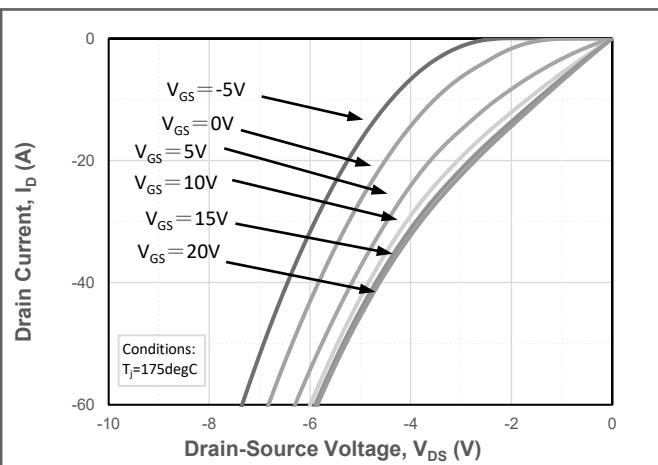


Fig.9 Reverse Output Characteristics at  $T_j = 175^\circ\text{C}$

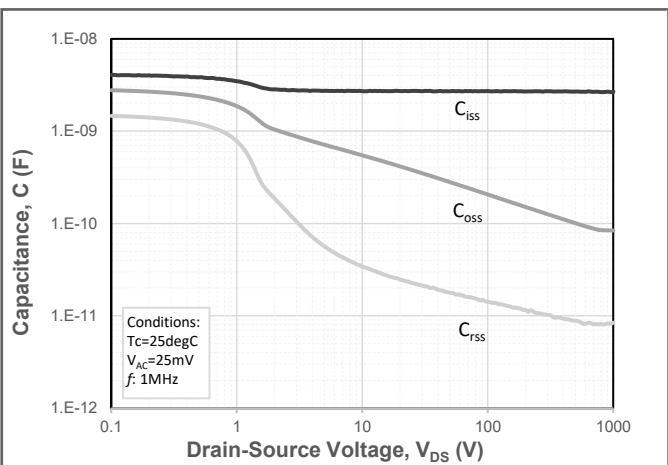


Fig.10 Capacitances vs. Drain to Source Voltage

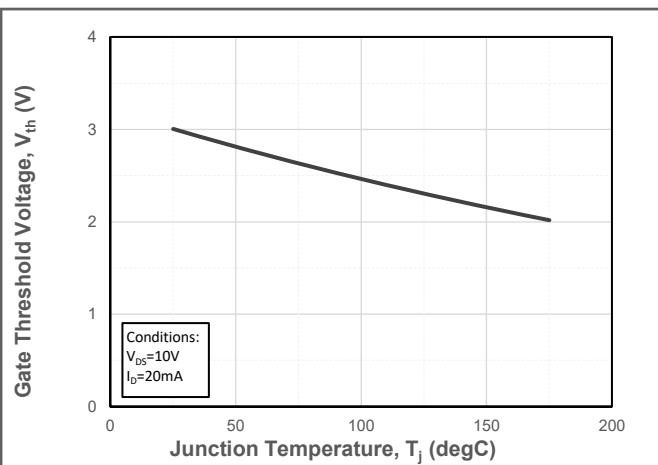


Fig.11 Threshold Voltage vs. Temperature

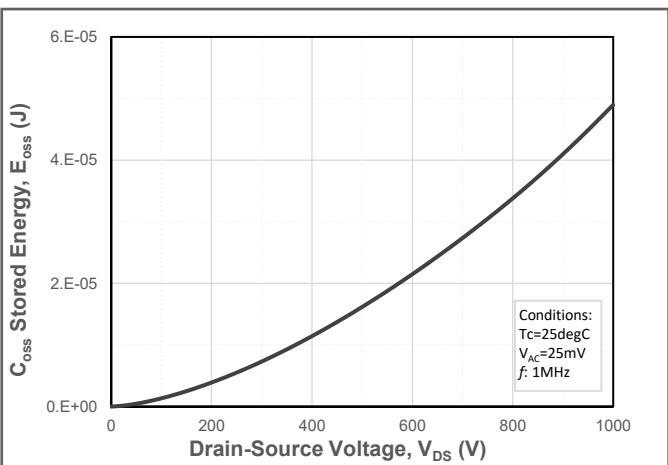
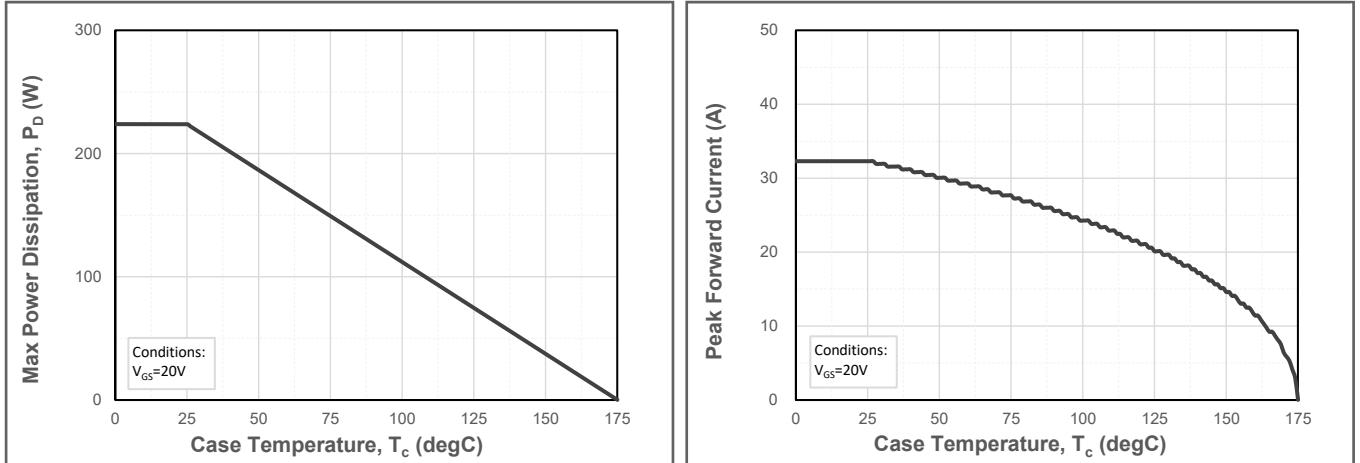


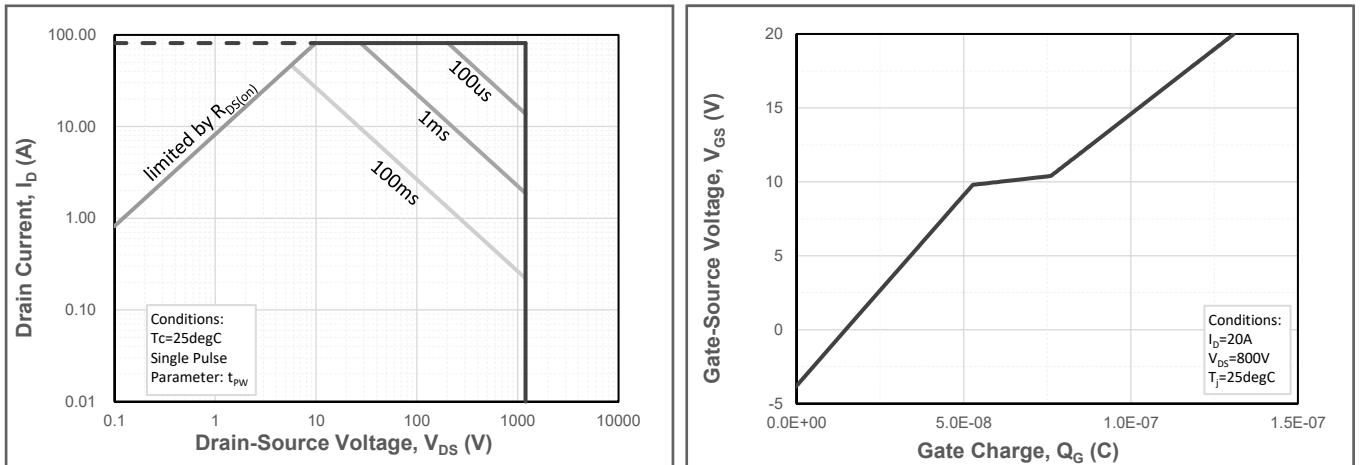
Fig.12 Output Capacitor Stored Energy

## Typical Device Performance



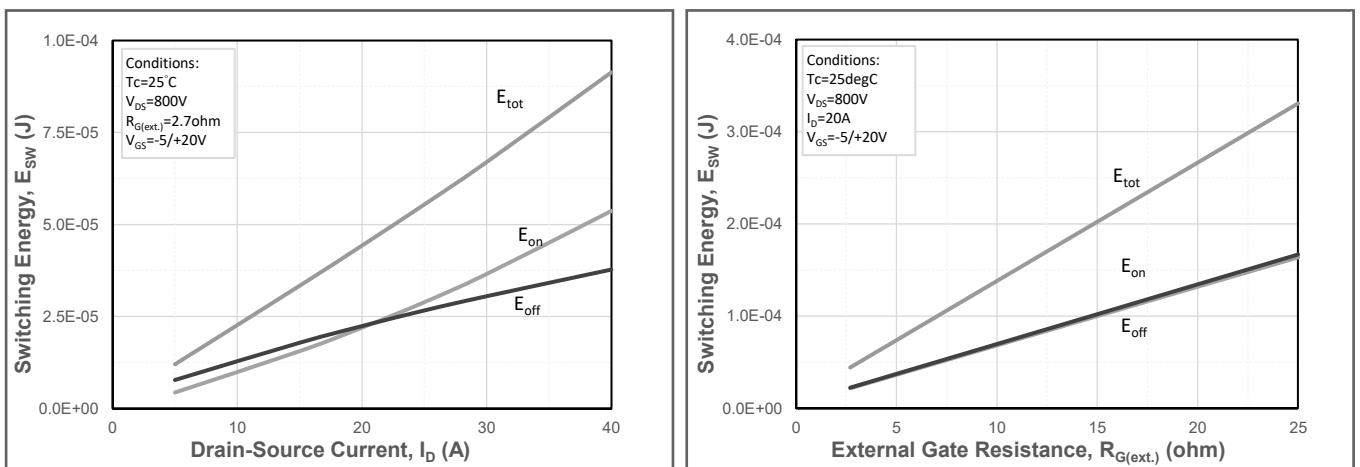
**Fig.13 Maximum Power Dissipation Derating vs. Case Temperature**

**Fig.14 Drain Current Derating vs. Case Temperature**



**Fig.15 Safe Operating Area**

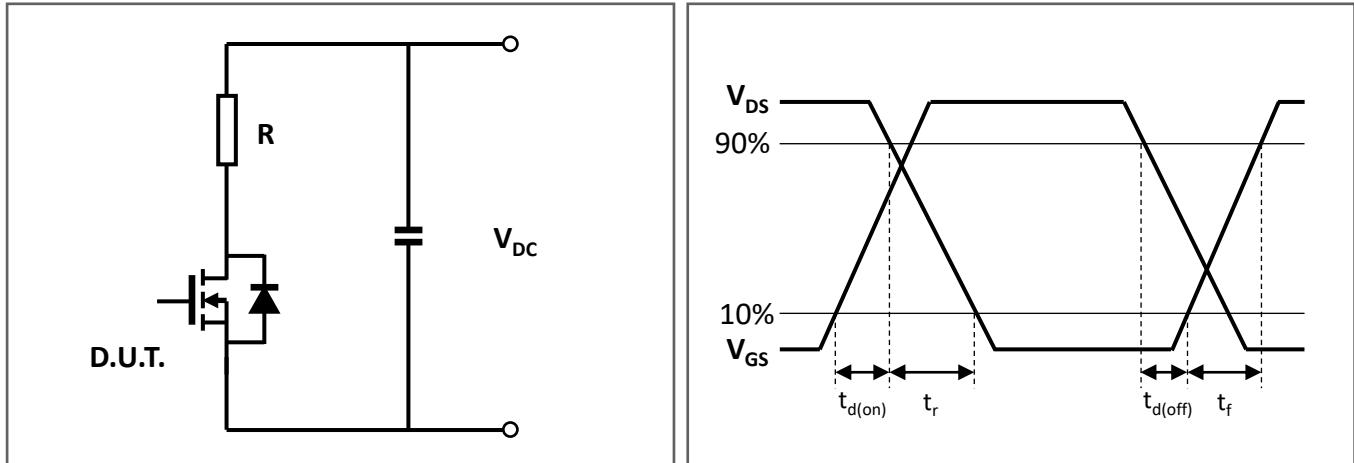
**Fig.16 Gate Charge Characteristics**



**Fig.17 Clamped Inductive Switching Energy vs. Drain Current**

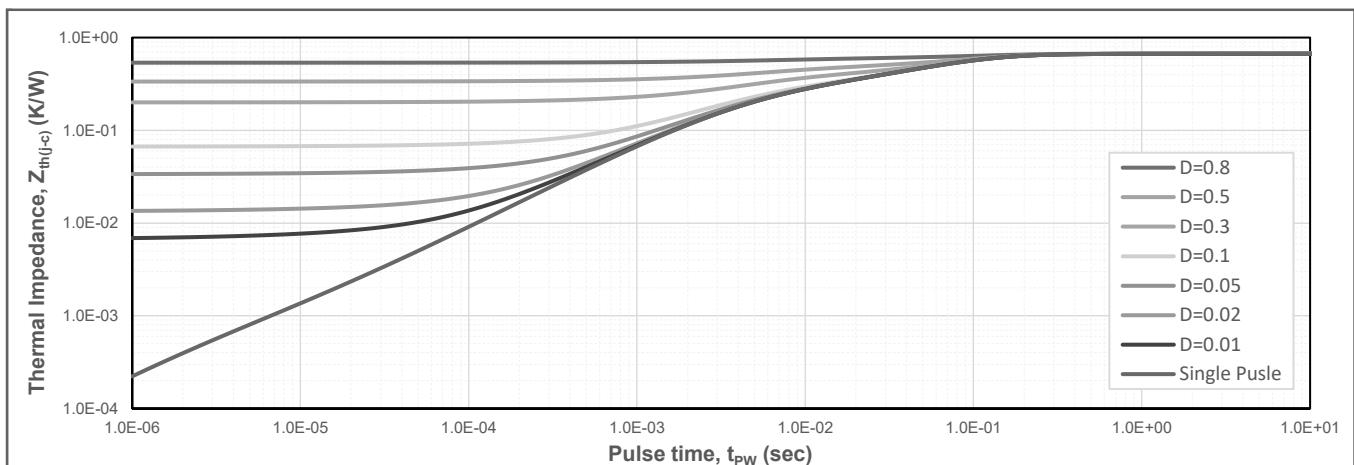
**Fig.18 Clamped Inductive Switching Energy vs. External Gate Resistor ( $R_{G(ext.)}$ )**

## Typical Device Performance



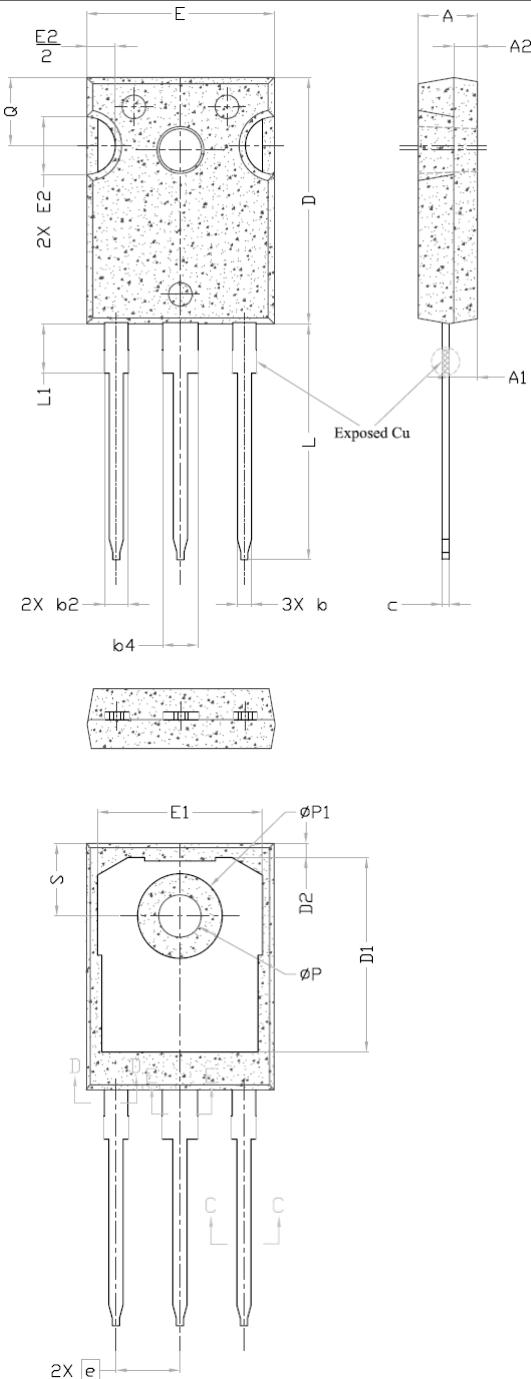
**Fig.19 Schematic of Resistive Switching**

**Fig.20 Switching Times Definition**



**Fig.21 Transient Junction to Case Thermal Impedance**

## Package Dimensions



SYMBOL	DIMENSIONS			Note
	Min.	Typ.	Max.	
A	4.83	5.02	5.21	
A1	2.29	2.41	2.55	
A2	1.50	2.00	2.49	
b	1.12	1.20	1.33	
b1	1.12	1.20	1.28	
b2	1.91	2.00	2.39	6
b3	1.91	2.00	2.34	
b4	2.87	3.00	3.22	6, 8
b5	2.87	3.00	3.18	
c	0.55	0.60	0.69	6
c1	0.55	0.60	0.65	
D	20.80	20.95	21.10	4
D1	16.25	16.55	17.65	5
D2	0.51	1.19	1.35	
E	15.75	15.94	16.13	4
E1	13.46	14.02	14.16	5
E2	4.32	4.91	5.49	3
e	5.44 BSC			
L	19.81	20.07	20.32	
L1	4.10	4.19	4.40	6
$\phi P$	3.56	3.61	3.65	7
$\phi P1$	7.19 REF.			
Q	5.39	5.79	6.20	
S	6.04	6.17	6.30	